Analytical Reference Materials International

Certificate of Analysis Certified Reference Material



Grade: AISI 316 / UNS S31600

Part Number (Q.A. NO.): IARM 5D

Certificate Date: 04/30/2003 Certificate No.: 5D-04302003-IARM-F Revision Date: 04/30/2003

Interpretation of Data

- 1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community.
- 2. Any data reported and enclosed by a **parentheses** () is a "best estimate" and is NOT CERTIFIED. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
- 3. The "Inter-laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets** [] **indicates further testing is in process.**
- 4. The "± Confidence Interval at 95%" is enclosed by a parentheses () below the individual element's concentration.

IMPORTANT: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

Aluminum 0.005 (0.001)	Boron (0.0005)	<u>Carbon</u> 0.021 (0.001)	Cobalt 0.143 (0.003)	Chromium 16.56 (0.05)	Copper 0.168 (0.003)	Manganese 1.78 (0.01)
2.11 (0.01)	Nitrogen 0.056 (0.001)	<u>Niobium</u> (0.004)	Nickel 10.38 (0.03)	Oxygen 0.0097 (0.0005)	Phosphorus 0.040 (0.001)	<u>Sulfur</u> 0.020 (0.0004)
Silicon 0.458 (0.007)	<u>Tin</u> 0.004 (0.001)	Titanium 0.008 (0.001)	Vanadium 0.029 (0.001)	Tungsten 0.016 (0.001)		

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

AK Steel, Butler Works - Butler, PA
Allvac Lockport - Lockport, NY
Carpenter Technology Corporation - Reading, PA
Conam Inspection - Gary, IN
Laboratory Testing, Inc. - Hatfield, PA

Timken Latrobe Steel Co. - Latrobe, PA

Allegheny Ludlum Corp. - Brackenridge, PA Anderson Laboratories, Inc. - Greendale, WI Chicago Spectro Service Laboratories - Chicago, IL Jorgensen Forge Corp. - Seattle, WA Lockheed Martin Astronautics - Littleton, CO Wisconsin Centrifugal, Inc. - Waukesha, WI

Traceability: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs and RMs applicable to the material covered by this certificate are: NIST 1226, 1261A, 1262A, 1265A, C1151, C1152, C1153, C1154, 1155, 1193, 1194, 1195, 1230, C2400, JSS 650, 651, 652, 653, 654, 655, BCS331, 332, 333, 334, 335, 336, 337, 338, ARMCO 8709, 8710, 8711, 8712, MBH14933, 14934, 14935, BSC 401/1, 402/1, 403/1, 404/1, 405/1, 406/1, 407/1, 408/1, 409/1, 410/1, IARM 1B, 2B, 4B, 5B, 9B, 11B, 152A, 157A162A, 163A, 205A, 27B, 28B, 29B, 30B, 31B, 32B, 33B, 34B, 35B, 36B, 48B, 49B, 155A, 156A, 164A, 165A, 166A, 167A, 168A, 169A, 170A, 171A, 172A, BS 84J, IARM 2A, 163A, 5A, NIST 1188, 1170A, 1184, NIST 121D, 160A, 133A, 1091A, IARM 5C, NIST 1761, 1762, 1763, 1764, 1765, 1766, 1767, 1155, 368, 15, RE 12, IARM 24A, LECO 501-553, 501-550, 762-747, BS 84J, JSS 190, BAS 66, CS 44C, NIST 15H, 343A, 73C, SS 466, AK 420400, 220790, B-85, 3505-2, BS 84J, CA316-3, LECO 502-106, IARM 5B, LECO 501-501, 501-533, IARM 5A, BS 317l, Cartech 316, NIST 160A, 443, 444, IARM 5A, 5B, 5C, 163A, 21B, LECO 501-676, 501-551, IS0049A, NIST 362, IARM 27B, LECO 501-647, NIST 1185, BS CA316-3, 316A, 84J, IARM 5C, LECO 502-106, 501-674, NIST 1155, C1152, BS CA316-1, 84J, LECO 502-106

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

See Reverse Side for Statistical Data and Additional Information Regarding this Material.

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 04/30/2003.

5D	Al	В	С	Co	Cr	Cu	Mn	Mo	N	Nb	Ni	0	P	S	Se
1	0.0036	< 0.00001	0.0236	0.146	16.40	0.172	1.77	2.07	0.052	0.003	10.39	0.0084	0.040	0.019	0.0001
2	0.0051	0.0011	0.0202	0.14879	16.62	0.1623	1.757	2.119	0.055	0.01659	10.470	0.0108	0.042	0.020	0.0001
3	0.006	0.0003	0.021	0.146	16.47	0.168	1.7930	2.146	0.0527	0.002	10.33	0.0104	0.0404	0.0210	0.0068
4	0.006	0.0005	0.0205	0.1417	16.540	0.174	1.77	2.12	0.0595	0.0057	10.322	0.0096	0.042	0.020	< 0.001
5	0.00714	0.00084	0.0215	0.138	16.700	0.169	1.801	2.097	0.0573	0.003	10.386	0.0096	0.0408	0.0203	0.002
6	0.0053	0.0002	0.0189	0.138	16.640	0.164	1.744	2.10	0.0549	0.004	10.298	0.0092	0.040	0.0204	0.001
7	0.004	0.0007	0.022	0.144	16.500	0.168	1.771	2.107	0.0558	< 0.001	10.421	0.0102	0.0404	0.0199	
8	0.0058	< 0.0003	0.020	0.149	16.50	0.167	1.80	2.106	0.0545	0.0133	10.36	0.0099	0.0392	0.020	
9		0.00045	0.023	0.141	16.59		1.77	2.11	0.0563	0.0067	10.31	0.0092	0.0395	0.021	
10			0.0190	0.144	16.618		1.795	2.10	0.0543	< 0.001	10.406		0.039	0.0213	
11			0.0188	0.146	16.51		1.78	2.083	0.0566	0.004	10.40			0.0198	
12			0.0183	0.137	16.65		1.792	2.12	0.0575	0.0003	10.438			0.0210	
13								2.119							
Mean	0.0054	0.0006	0.0206	0.1433	16.5615	0.1680	1.7786	2.1075	0.0555	0.0059	10.3776	0.0097	0.0403	0.0203	0.0020
STDV.	0.0011	0.0003	0.0017	0.0041	0.0883	0.0038	0.0180	0.0189	0.0021	0.0052	0.0541	0.0007	0.0010	0.0007	0.0028
Certified	0.005	(0.0005)	0.021	0.143	16.56	0.168	1.78	2.11	0.056	(0.004)	10.38	0.0097	0.040	0.020	< 0.001
95% C.I.	0.001		0.001	0.003	0.05	0.003	0.01	0.01	0.001		0.03	0.0005	0.001	0.0004	
Methods	X,O	О	C,O	X,I,O	X,W,O	X,I,O	X,O	X,I,O	F	X,O	X,W,O	F	X,I,O	C,O	X,A,O

Met	thods: W =	Classical,	C = Comb	oustion, F	= Fusion,	A = AA or	GFAA, I =	ICP or DC	P, D = DC	Arc, O = (DE, X = XR	RF, G=GDN	ЛS
Si	Sn	Ta	Ti	V	W	Ag	As	Bi	Ca	H	Mg	Pb	1
0.467	0.003	0.008	0.0065	0.0259	0.01787	< 0.0001	0.0043	0.0006	0.0383	0.0001	< 0.0001	0.0021	0.0

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1	0.467	0.003	0.008	0.0065	0.0259	0.01787	< 0.0001	0.0043	0.0006	0.0383	0.0001	< 0.0001	0.0021	0.0028	0.0031
2	0.4706	0.0059	0.0079	0.008	0.030	0.0168		0.0037	0.0001	0.0019		0.0048	0.0010	< 0.0001	< 0.0001
3	0.474	0.003	0.0083	0.0090	0.0294	0.014		0.0029	0.0021	0.0012		0.001	0.0010		0.0027
4	0.451	0.0045	< 0.01	0.0074	0.030	0.015		0.0117	0.00071			< 0.0005	< 0.0005		0.0070
5	0.458	0.006	0.006	0.006	0.0267	0.015		< 0.01	< 0.001				0.00564		
6	0.452	0.0064	0.002	0.00951	0.028	0.0160		0.0040					0.0002		
7	0.462	0.0034		0.0072	0.031	0.017							0.0007		
8	0.459	0.0032		0.007	0.029										
9	0.438	0.0038		0.0074											
10	0.450														
11	0.460														
Mean	0.4583	0.0044	0.0064	0.0076	0.0288	0.0160	#DIV/0!	0.0053	0.0009	0.0138	0.0001	0.0029	0.0018	0.0028	0.0043
STDV.	0.0103	0.0014	0.0026	0.0011	0.0018	0.0014	#DIV/0!	0.0036	0.0009	0.0212	#DIV/0!	0.0027	0.0020	#DIV/0!	0.0024
Certified	0.458	0.004	(0.008)	0.008	0.029	0.016		(0.004)	< 0.001				(0.002)		
95% C.I.	0.007	0.001		0.001	0.001	0.001									
Methods	X,W,O	X,O	X,I,O	X,I,O	X,I,O	X,O		X,D,A,O	X,D,A,O				X,D,A,O		

Methods: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G=GDMS

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1981-(E) list the following:

<u>Certifying Body:</u> A technically competent body (organization or firm, public or private) that issues a Reference Material Certificate. The only generally accepted certifying body in the United States is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD

Reference Material (RM): A material or substance with one or more properties which are sufficiently well established to be used for calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

<u>Certified Reference Material (CRM):</u> A reference material with one or more properties whose values are certified by a technically valid procedure accompanied by or traceable to a certificate or other documentation, which is issued by a Certifying Body.

<u>Inter-Laboratory Analysis Program (ILAP):</u> Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter-laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol and treatment of data resulting from this inter-laboratory program were performed utilizing the guidelines established in ASTM E691-87.

Methods of Analysis: In view of the fact, that the "Inter-Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen and Oxygen are the result of combustion instrument procedures.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length. The majority of materials are in wrought condition. Other methods of manufacture are utilized as a last resort, only in the case of those materials being unavailable in wrought condition. "Batch" samples are taken by removing a one-inch cross section for every thirteen inches of total length from the entire bar. Twenty-five percent of the one inch cross section is converted to chips for analysis by classical wet chemistry, ICP, AA, and combustion procedures and seventy-five percent remains in a solid disk form for OES and X-Ray analysis where applicable. Each member of the ILAP is furnished both a solid sample and the corresponding supply of chips from a specific location on the batch bar. This massive sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data.

Certified by:

William D. Britt, President & General Manager Analytical Reference Materials International Corporation Certificate No.: 5D-04302003-IARM-F Certificate Date: 04/30/2003

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